

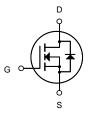
Description

The SQ4470EY uses advanced trench technology to provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.



SOP-8

(SOIC-8)



N-Channel MOSFET

General Features

 $V_{DS} = 60V I_{D} = 10 A$

 $R_{DS(ON)} < 13m\Omega$ @ $V_{GS}=10V$

 $R_{DS(ON)} < 15m\Omega$ @ $V_{GS}=4.5V$

Application

Battery protection

Load switch

Uninterruptible power supply

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
SQ4470EY	SOP-8(SOIC-8)	HXY MOSFET	3000

Absolute Maximum Ratings (Tc=25℃unless otherwise noted)

Symbol	Parameter	Limit	Unit
V _{DS}	Drain-Source Voltage	60	V
Vgs	Gate-Source Voltage	±20	V
I D	Drain Current-Continuous	10	Α
I _D (100℃)	Drain Current-Continuous(Tc=100℃)	8.5	А
lом	Pulsed Drain Current	30	А
P _D	Maximum Power Dissipation	3	W
T _J ,T _{STG}	Operating Junction and Storage Temperature Range	-55 To 150	$^{\circ}\!\mathbb{C}$



Electrical Characteristics (TC=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics			•			
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	60		-	V
Zero Gate Voltage Drain Current	I _{DSS}	V_{DS} =60V, V_{GS} =0V	-	-	1	μΑ
Gate-Body Leakage Current	I _{GSS}	$V_{GS}=\pm20V, V_{DS}=0V$	-	-	±100	nA
On Characteristics (Note 3)			•			
Gate Threshold Voltage	V _{GS(th)}	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	0.9	1.3	1.8	V
Dunin Course On State Besistance	R _{DS(ON)}	V _{GS} =10V, I _D =10A	-	10	13	mΩ
Drain-Source On-State Resistance		V _{GS} =4.5V, I _D =5A	-	11.5	15	mΩ
Forward Transconductance	g FS	V _{DS} =5V,I _D =12A	40	-	-	S
Dynamic Characteristics (Note4)			•			
Input Capacitance	C _{lss}	V 20V/V 0V	-	4100	-	PF
Output Capacitance	Coss	V_{DS} =30V, V_{GS} =0V, F=1.0MHz	-	298	-	PF
Reverse Transfer Capacitance	C _{rss}	F=1.UIVIHZ	-	229	-	PF
Switching Characteristics (Note 4)			•			
Turn-on Delay Time	t _{d(on)}		-	8.5	-	nS
Turn-on Rise Time	t _r	V_{DD} =30V, R_L =1 Ω	-	7	-	nS
Turn-Off Delay Time	t _{d(off)}	V_{GS} =10 V , R_{GEN} =3 Ω	-	40	-	nS
Turn-Off Fall Time	t _f		-	15	-	nS
Total Gate Charge	Qg	V 20VI 40A	-	93	-	nC
Gate-Source Charge	Q _{gs}	V _{DS} =30V,I _D =10A,	-	9.7	-	nC
Gate-Drain Charge	Q_{gd}	V _{GS} =10V	-	20	-	nC
Drain-Source Diode Characteristics			•			
Diode Forward Voltage (Note 3)	V_{SD}	V _{GS} =0V,I _S =10A	-	-	1.2	V
Diode Forward Current (Note 2)	Is		-	-	10	А
Reverse Recovery Time	t _{rr}	$T_J = 25^{\circ}C, I_F = 10A$	-	32	-	nS
Reverse Recovery Charge	Qrr	$di/dt = 100A/\mu s^{(Note3)}$	-	45	-	nC

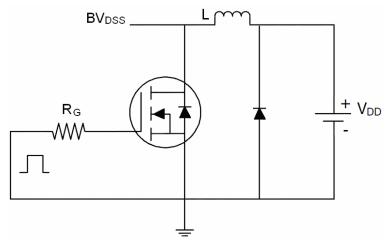
Notes:

- **1.** Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. The value of $R_{\theta JA}$ is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The value in any given application depends on the user's specific board design.
- 3. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 4. Guaranteed by design, not subject to production

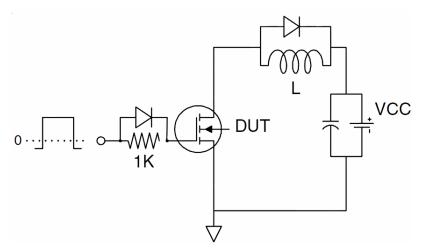


Test Circuit

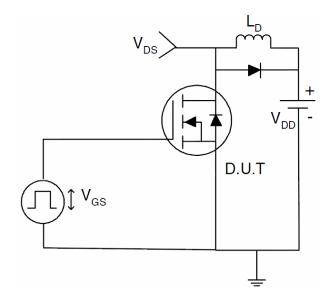
1) E_{AS} test Circuit



2) Gate charge test Circuit



3) Switch Time Test Circuit





Typical Electrical and Thermal Characteristics (Curves)

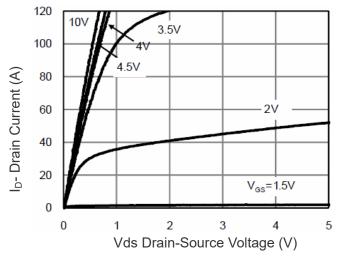


Figure 1 Output Characteristics

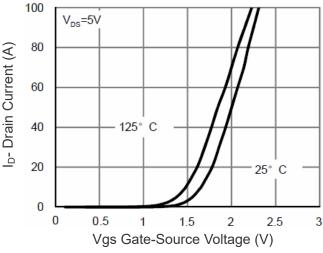


Figure 2 Transfer Characteristics

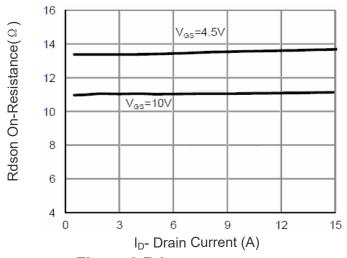


Figure 3 Rdson- Drain Current

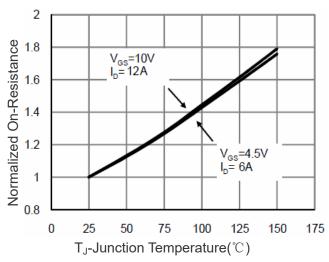


Figure 4 Rdson-JunctionTemperature

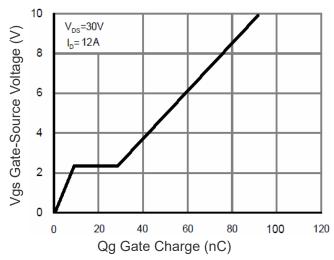


Figure 5 Gate Charge

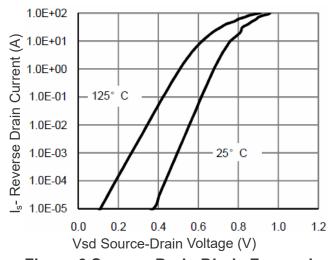
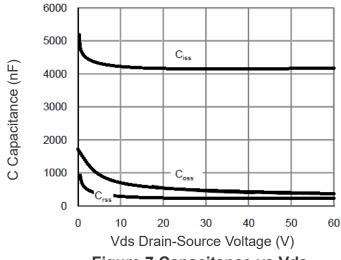


Figure 6 Source- Drain Diode Forward

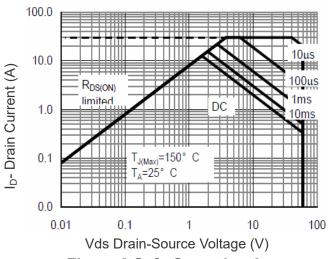




16 14 12 Drain Current (A) 10 8 4 2 0 25 50 100 0 75 125 150 T_J-Junction Temperature(℃)

Figure 7 Capacitance vs Vds

Figure 9 Current De-rating



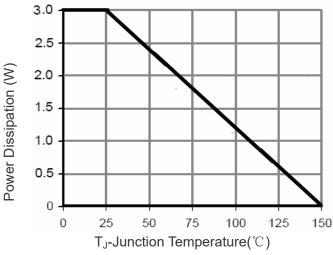
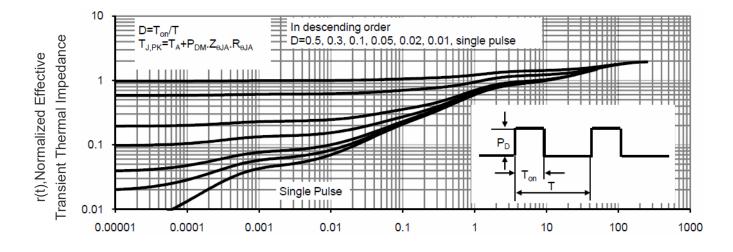


Figure 8 Safe Operation Area

Figure 10 Power De-rating

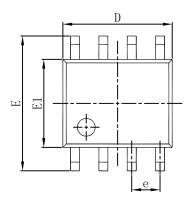


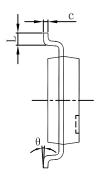
Square Wave Pluse Duration(sec)

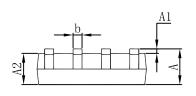
Figure 11 Normalized Maximum Transient Thermal Impedance



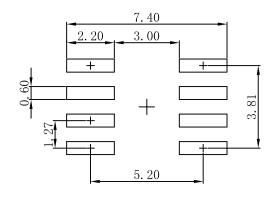
SOP-8(SOIC-8) Package Outline Dimensions







Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min	Max	Min	Max	
A	1.350	1.750	0.053	0.069	
A1	0. 100	0. 250	0.004	0.010	
A2	1. 350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
С	0. 170	0. 250	0.007	0.010	
D	4.800	5. 000	0. 189	0. 197	
e	1.270 (BSC)		0.050 (BSC)		
E	5. 800	6. 200	0. 228	0. 244	
E1	3.800	4.000	0. 150	0. 157	
L	0.400	1. 270	0.016	0.050	
θ	0°	8°	0°	8°	



- Note:
 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.

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